## CLAIMS-

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- 1) A method of cutting a substrate comprising the steps of:
  - a) providing a laterally disposed substrate;
  - b) focussing a first laser beam onto a first laser focus point on the substrate;
  - c) focussing a second laser beam onto a second laser focus point on the substrate, the second laser focus point being relatively vertically displaced from the said first laser focus point; and
  - d) effecting relative lateral movement between the said substrate and the said first and second laser focus points respectively so that the said first laser focus point follows a cutting path on the said substrate, the said second laser focus point also following the said cutting path but being relatively vertically displaced from the said first laser focus point, a first layer of the said substrate being removed along the cutting path by the first laser beam and a second layer of the said substrate being removed along the cutting path by the second laser beam.
- 2) A method according to claim 1 wherein both first and second laser beams irradiate the same lateral face of the substrate.
- A method according to claim 1 wherein the first and second laser beams irradiate first and second lateral faces of the substrate respectively.

| Sulo,                                  | 4) | A method according to any previous claim wherein the substrate |
|--|----|--|
| , K                                    |    | is composed of plural layers.                                  |
|  | 5) | A method according to claim 4 wherein further laser beams are  |
| _                                      |    | provided, the number of laser beams corresponding to the       |
| 5                                      |    | number of separate layers to be removed.                       |
|  | 6) | A method according to claim 4 or claim 5 wherein each said     |
| X                                      |    | layer comprises different materials or combinations of         |
|  |    | materials.   |
| · ;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;;; | 7) | A method according to claim 6 wherein the properties of each   |
| 10                                     |    | said respective laser beam are selected so as to be suitable   |
|  |    | for the removal of the particular layer or layers to be        |
|  |    | removed thereby.   |
|  | 8) | A method according to any previous claim including the         |
| <b>₽</b> √3                            |    | additional step of optically monitoring the cutting region,    |
| 15 L                                   |    | the cutting process being controlled in response to the said   |
|  |    | optical monitoring.  |
|  | 9) | Apparatus for cutting a substrate comprising:                  |
|  |    | a) means for supporting a laterally disposed substrate;        |
|  |    | b) means for generating a first laser beam which in use is     |
| 20                                     |    | focussed onto a first laser focus point on the substrate;      |
|  |    | c) means for generating a second laser beam which in use is    |
|  |    | focussed onto a second laser focus point on the substrate,     |
|  |    | the second laser focus point being relatively vertically       |
|  |    | displaced from the said first laser focus point; and           |
| 25                                     |    | d) means for effecting relative lateral movement between the   |
|  |    | said substrate and the said first and second laser focus       |

points respectively so that the said first laser focus

|       |        |     | point follows a cutting path on the said substrate, the      |
|-------|--------|-----|--|
|       |        |     | said second laser focus point also following the said        |
|       | _      |     | cutting path but being relatively vertically displaced       |
|       | 5      |     | from the said first laser focus point, a first layer of      |
|       |        |     | the said substrate being removed along the cutting path by   |
|       |        |     | the first laser beam and a second layer of the said          |
|       |        |     | substrate being removed along the cutting path by the        |
|       |        |     | second laser beam.   |
|       | 10     | 10) | Apparatus according to claim 9 wherein the first and second  |
|       |        |     | laser beams are arranged so as to irradiate the same lateral |
|       |        |     | face of the substrate.                                       |
| :     |        | 11) | Apparatus according to claim 9 wherein the first and second  |
| id.   |        |     | laser beams are arranged so as to irradiate first and second |
|       | 15     |     | lateral faces of the substrate respectively.                 |
| T. Au | Jq.    | 12) | Apparatus according to any previous claim wherein the        |
|       | By.    |     | substrate is composed of plural layers.                      |
|       |        | 13) | Apparatus according to claim 12 wherein further laser beams  |
|       |        |     | are provided, the number of laser beams corresponding to the |
|       | 20     |     | number of separate layers to be removed.                     |
| Sub   |        | 14) | Apparatus according to any of claims 9 - 13 wherein at least |
|       | ر<br>ا |     | two of the said laser beams provide laser light having       |
| +     | ?      |     | different parameters.  |
|       |        | 15) | Apparatus according to claim 14 wherein the said parameters  |
|       | 25     |     | include one or more of wavelength, pulse duration and        |
|       |        |     | intensity.   |
|       |        |     |  |

| 5  | ale sale | 16) | Apparatus according to any of flaims 12 - 15 wherein each said layer comprises different materials or combinations of |
|----|----------|-----|---|
|    | ۲,       |     | materials.  |
| •  |          | 17) | Apparatus according to claim 16 wherein the properties of each  |
|    | 5        |     | said respective laser beam are selected so as to be suitable  |
|    |          |     | for the removal of the particular layer or layers to be   |
|    | ••       |     | removed thereby.  |
|    |          | 18) | Apparatus according to any of claims 9 - 17 wherein beam  |
|    | SWPN     | Λ   | splitter means are provided so that at least two laser beams  |
|    | 10       |     | are derived from the same laser source.   |
|    |          | 19) | Apparatus according to any of claims 9 - 18 wherein optical   |
|    |          |     | monitoring means are provided for optically monitoring the  |
|    | ,        |     | cutting region, means being provided to control the cutting   |
|    |          |     | process in response to the said optical monitoring.   |
|    | 15       | 20) | A method substantially as herein described and illustrated in   |
| IJ |          |     | the accompanying drawings.  |
|    |          | 21) | Apparatus substantially as herein described and illustrated in  |
| •  | •        |     | the accompanying drawings.  |